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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/630,022	BOWEN ET AL.	
Examiner	Art Unit	
Shruti S. Costales	1714	

	SEAR	CHED	
Class	Subclass	Date	Examiner
524	261 262 267 393 492 543 572	4/27/2005	SSC
523	200 202	4/27/2005	ssc
523	212 216	4/27/2005	ssc
152	905 209.1	4/29/2005	ssc
Above	Updated	11/3/2005	ssc

INT	TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated inventor and assignee search (see search history printout)	11/2/2005	ssc
East (USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB) - see search history printout	11/3/2005	SSC
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